

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: A. Sargent et al

Group Art Unit: : Endicott Interconnect Technologies, Inc.

Examiner: : IP Law, FBU/257-2 AA12

Serial No.: : 1701 North Street

Filed: Herewith : Endicott, New York 13760

Title: Circuit Substrate and Method Of Making

Same

Assistant Commissioner For Patents

Washington, D.C. 20231

Dear Sir:

INFORMATION DISCLOSURE STATEMENT/CERTIFICATION

For ensuring compliance with Applicant's/Applicants' duty of disclosure under 37 CFR § 1.56, the undersigned hereby submits the documents listed on the attached Form PTO-1449 for consideration by the Examiner in charge of the above-identified patent application.

The listing of these documents is not to be construed as an admission that such is actually prior art with respect to the invention of the present application and is not to be construed that such is material with respect to the present invention.

[] U.S. patent applications which Applicant/Applicants considers/consider to be related to the above-identified application.



[]	A concise explanation of the relevance of the non-English language documents is attached:
[]	The relevance of the documents is indicated on the enclosed copy of the Search Report for the priority application
	These documents are being submitted (check only one of the next four boxes):
{ X }	within three months of the filing of the above U.S. national application or of the date of entry of the U.S. national stage in an International Patent Application (no fee is due);
[]	before receiving a first Office Action on the merits of the above-identified patent application (no fee is due);
[]	following receipt of a first Office Action, but before issuance of a Final Office Action or a Notice of Allowance (if this box is checked, the fee box below or one of the last two boxes must be checked);
	<u>OR</u>
[]	following receipt of a Notice of Allowance or a Final Office Action (if this box is checked, the fee box and one of the last two boxes also must be checked).



CERTIFICATION

- [] The undersigned certifies that each item of this information is being submitted within three months of the date it was first cited in any communication from a foreign patent office in a counterpart foreign application.
- [] The undersigned certifies that no item of information contained in the information disclosure statement was first cited in a communication from a foreign patent office in a counterpart foreign application, and, to the knowledge of the undersigned, after making reasonable inquiry, no item of information contained in the information disclosure statement was known to any individual designated in 37 CFR § 1.56(c) more than three months prior to the filing of this information disclosure statement.

By:

Respectfully submitted,

Telephone: 607-755-3207 Fax: 607-755-6151

Attorney for Applicant/Applicants

Reg. No. 26.885

NUMBER	FORM PTO 1449 (Modified)				7	ATTY. DOCKET NO. EI-2-03-009 SERIAL NO. N/A									
Page 1	PUBLICATIONS FOR APPLICANT'S INFORMATION					APPLICANT: A. Sargent et al									
EXAMINER DOCUMENT NUMBER DATE NAME CLASS SUBCLASS FILIT DATE	1				. [FILING DATE HEREWITH C				GROUP N/A					
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AA 5,106,473 04/92 Whitlaw et al		2				DAT	——- Е	NAME			CLAS	s	SUBCLA	ASS	FILING DATE
AB 5,300,208 04/94 Angelopoulos et al AC 5,427,841 06/95 De Leeuw et al AD 5,620,800 04/97 De Leeuw et al AE 5,818,700 10/98 Purinton AF 5,854,514 12/98 Roldan et al AG 5,986,046 11/99 Nishiyama et al AI A			AA	 		}									
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